

October 2013

FDME410NZT

N-Channel PowerTrench® MOSFET 20 V, 7 A, 26 m Ω

Features

- Max $r_{DS(on)}$ = 26 m Ω at V_{GS} = 4.5 V, I_D = 7 A
- Max $r_{DS(on)} = 31 \text{ m}\Omega$ at $V_{GS} = 2.5 \text{ V}$, $I_D = 6 \text{ A}$
- Max $r_{DS(on)} = 39 \text{ m}\Omega$ at $V_{GS} = 1.8 \text{ V}$, $I_D = 5 \text{ A}$
- Max $r_{DS(on)}$ = 53 m Ω at V_{GS} = 1.5 V, I_D = 4 A
- Low profile: 0.55 mm maximum in the new package MicroFET 1.6x1.6 **Thin**
- Free from halogenated compounds and antimony oxides
- HBM ESD protection level > 1800V (Note3)
- RoHS Compliant

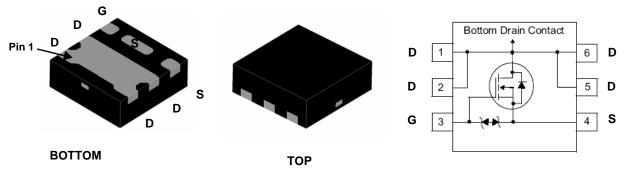


General Description

This Single N-Channel MOSFET has been designed using Fairchild Semiconductor's advanced Power Trench process to optimize the $r_{DS(ON)} \ @ \ VGS = 1.5 \ V$ on special MicroFET leadframe.

Applications

- Li-Ion Battery Pack
- Baseband Switch
- Load Switch
- DC-DC Conversion



MicroFET 1.6x1.6 Thin

MOSFET Maximum Ratings $T_A = 25$ °C unless otherwise noted

Symbol	Paramet	Parameter			
V_{DS}	Drain to Source Voltage			20	V
V_{GS}	Gate to Source Voltage			±8	V
1	Drain Current -Continuous	T _A = 25 °C	(Note 1a)	7	А
'D	-Pulsed			15	_ ^
D	Power Dissipation for Single Operation	T _A = 25 °C	(Note 1a)	2.1	W
P_{D}	Power Dissipation for Single Operation	T _A = 25 °C	(Note 1b)	0.7	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	60	°C/W
RAIA	Thermal Resistance, Junction to Ambient	(Note 1b)	175	10/00

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
6T	FDME410NZT	MicroFET 1.6x1.6 Thin	7 "	8 mm	5000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV_DSS	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	20			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		18		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 16 V, V _{GS} = 0 V			1	μΑ
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	0.4	0.7	1.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		-3		mV/°C
	$V_{GS} = 4.5 \text{ V}, I_D = 7 \text{ A}$		19	26		
	r _{DS(on)} Drain to Source On Resistance	$V_{GS} = 2.5 \text{ V}, I_D = 6 \text{ A}$		20	31	mΩ
r		$V_{GS} = 1.8 \text{ V}, I_D = 5 \text{ A}$		24	39	
'DS(on)		$V_{GS} = 1.5 \text{ V}, I_D = 4 \text{ A}$		31	53	11152
	$V_{GS} = 4.5 \text{ V}, I_D = 7 \text{ A},$ $T_J = 125 ^{\circ}\text{C}$		24	36		
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 7 A		35		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 40 V V 0 V	770	1025	pF
Coss	Output Capacitance	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	115	155	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 101112	75	115	pF
R _a	Gate Resistance		1.9		Ω

Switching Characteristics

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$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	t _{d(on)}	Turn-On Delay Time		7.3	15	ns
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	t _r	Rise Time	$V_{DD} = 10 \text{ V}, I_D = 7 \text{ A}$	3.4	10	ns
Q_g Total Gate Charge Q_{gs} Gate to Source Gate Charge $V_{DD} = 10 \text{ V}, I_D = 7 \text{ A}$ $V_{CS} = 4.5 \text{ V}$	t _{d(off)}	Turn-Off Delay Time	V _{GS} = 4.5 V, R _{GEN} = 612	27	43	ns
Q_{gs} Gate to Source Gate Charge $V_{DD} = 10 \text{ V}, I_D = 7 \text{ A}$ $V_{CS} = 4.5 \text{ V}$	t _f	Fall Time		3.2	10	ns
Q_{gs} Gate to Source Gate Charge $V_{DD} = 10 \text{ V}, I_D = 7 \text{ A}$ 1.1 nC Q_{gd} Gate to Drain "Miller" Charge 1.6 nC	Q_g	Total Gate Charge	V 40 V 1 7 A	9.2	13	nC
Q _{od} Gate to Drain "Miller" Charge	Q_{gs}	Gate to Source Gate Charge	$V_{DD} = 10 \text{ V}, I_D = 7 \text{ A}$	1.1		nC
	Q_{gd}	Gate to Drain "Miller" Charge	VGS = 4.0 V	1.6		nC

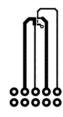
Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 1.6 A (Note 2)		0.7	1.2	V
t _{rr}	Reverse Recovery Time	L - 7 A di/dt - 100 A/vo		15	27	ns
Q _{rr}	Reverse Recovery Charge	I _F = 7 A, di/dt = 100 A/μs		3.5	10	nC

^{1.} R_{0,1A} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,1C} is guaranteed by design while R_{0,1C} is determined by the user's board design.



a. 60 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 175 °C/W when mounted on $\,a$ minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3. The diode connected between the gate and source serves only as protection ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25 °C unless otherwise noted

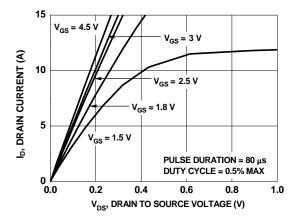


Figure 1. On-Region Characteristics

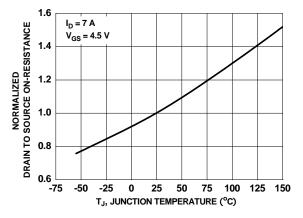


Figure 3. Normalized On-Resistance vs Junction Temperature

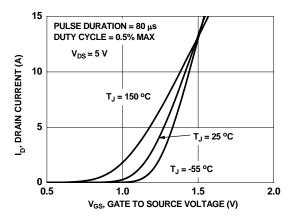


Figure 5. Transfer Characteristics

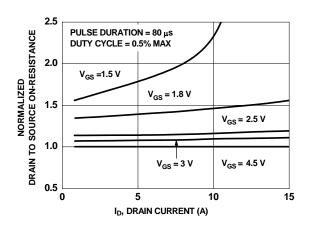


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

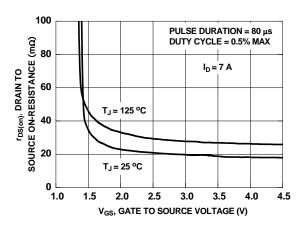


Figure 4. On-Resistance vs Gate to Source Voltage

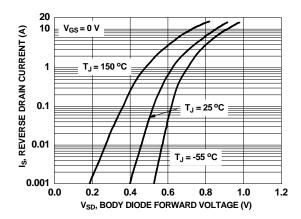


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25 °C unless otherwise noted

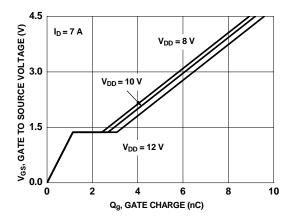


Figure 7. Gate Charge Characteristics

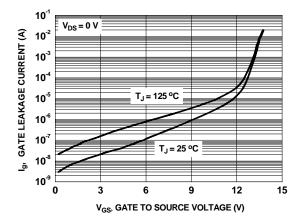


Figure 9. Gate Leakage Current vs Gate to Source Voltage

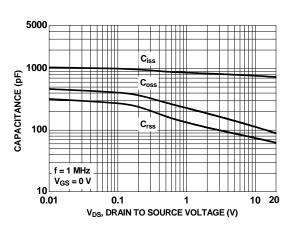


Figure 8. Capacitance vs Drain to Source Voltage

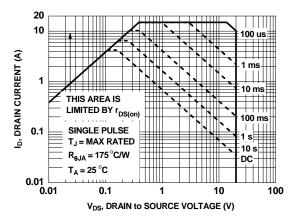


Figure 10. Forward Bias Safe Operating Area

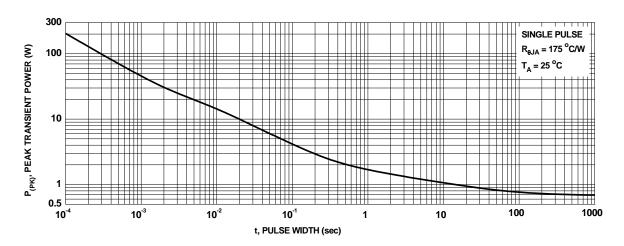


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

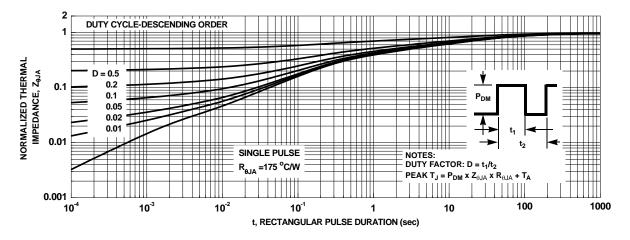
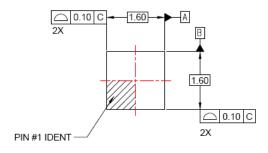
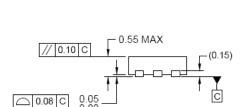


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

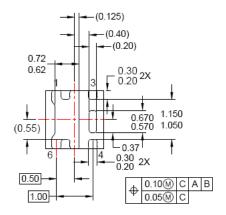
Dimensional Outline and Pad Layout

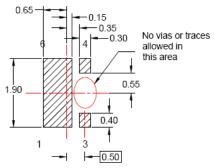


TOP VIEW

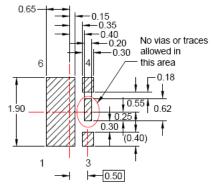


SIDE VIEW





RECOMMENDED LAND PATTERN OPT 1



RECOMMENDED LAND PATTERN OPT 2

NOTES:

- A. DOES NOT FULLY CONFORM TO JEDEC REGISTRATION
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
- D. LAND PATTERN RECOMMENDATION IS BASED ON FSC DESIGN ONLY





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